

**Search Notes**

Application/Control No.

10/762,767

Examiner

Seung H. Lee

Applicant(s)/Patent under  
Reexamination

WURZBURG ET AL.

Art Unit

2876

**SEARCHED**

Class	Subclass	Date	Examiner
235	376, 382.5	9/26/2006	SHL
235	435,439	9/26/2006	SHL
235	441	9/26/2006	SHL

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
Same as	Above	9/26/2006	SHL

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
235/382 (see printouts)	9/26/2006	SHL
700/300, 320-324(see printouts)	9/26/2006	SHL
10/762,684 and cited arts	9/26/2006	SHL
PCT cites	9/26/2006	SHL
NPL	9/26/2006	SHL